

<b>Notice of References Cited</b>	Application/Control No. 10/814,169		Applicant(s)/Patent Under Reexamination INOUE, SATOSHI	
	Examiner David Nhu		Art Unit 2818	Page 1 of 1

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*	C	US-5,466,631	11-1995	Ichikawa et al.	438/406
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	M	US-			

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**NON-PATENT DOCUMENTS**

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